Application/Control No. Applicant(s)/Patent Under Reexamination 10/828,662 KITANO, SHUHEI **Notice of References Cited** Examiner Art Unit Page 1 of 1 Deborah Yee 1742 U.S. PATENT DOCUMENTS **Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,740,175 05-2004 Kitano, Shuhei Α 148/328 US-В US-С D US-Ε US-F US-G US-US-Н USı J US-Κ US-US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 411131176 05-1999 Japan Hoshino, Toshiyuki et al c22c 38/00 0 Ρ Q R S Т **NON-PATENT DOCUMENTS**

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